# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SHENKAR, EMANUEL | Examiner | Art Unit | Page 1 of 4

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,473,163	09-1984	Geiger, Eduard	215/250
	В	US-4,679,696	07-1987	Bonnenfant et al.	215/252
	С	US-4,694,969	09-1987	Granat, Rodney J.	215/252
	D	US-4,694,970	09-1987	Hayes, Thomas H.	215/252
	Е	US-4,705,183	11-1987	Moloney, John J.	215/276
	F	US-4,782,968	11-1988	Hayes, Thomas H.	215/276
	G	US-4,801,031	01-1989	Barriac, Jacques J.	215/252
	Н	US-4,813,561	03-1989	Ochs, Charles S.	215/252
	1	US-4,852,753	08-1989	Ochs, Charles S.	215/271
	J	US-4,880,127	11-1989	Doi, Kouichi	215/252
	к	US-4,989,740	02-1991	Vercillo, Peter A.	215/252
	L	US-4,993,572	02-1991	Ochs, Charles S.	215/260
	М	US-5,007,545	04-1991	Imbery, Jr., Leo R.	215/14

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
`	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SHENKAR, EMANUEL Examiner | Art Unit | Page 2 of 4

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,009,324	04-1991	Ochs, Charles S.	215/276
	В	US-5,027,964	07-1991	Banich, Sr., John N.	215/252
	С	US-5,031,787	07-1991	Ochs, Charles S.	215/276
	D	US-5,058,755	10-1991	Hayes, Thomas H.	215/252
	E	US-5,062,538	11-1991	Ochs, Charles S.	215/260
	F	US-5,078,290	01-1992	Ochs, Charles S.	215/276
	G	US-5,258,191	11-1993	Hayes, Thomas H.	426/107
	Н	US-5,341,949	08-1994	Hayes, Thomas H.	215/253
	1	US-5,346,082	09-1994	Ochs et al.	215/252
	J	US-5,400,913	03-1995	Kelly, Ronald L.	215/252
	К	US-5,443,853	08-1995	Hayes, Thomas H.	426/107
	L	US-5,660,290	08-1997	Hayes, Thomas H.	215/252
	М	US-5,685,443	11-1997	Taber et al.	215/252

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date ·MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	Q					
	R					
	S					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited

Application/Control No.

10/076,722

Examiner

James N. Smalley

Applicant(s)/Patent Under
Reexamination
SHENKAR, EMANUEL

Page 3 of 4

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,755,347	05-1998	Ingram, Keith W.	215/252
	В	US-5,775,527	07-1998	Bosl et al.	215/252
	С	US-5,839,592	11-1998	Hayes, Thomas H.	215/230
•	D	US-5,884,790	03-1999	Seidita, Thomas M.	215/330
	E	US-5,967,351	10-1999	Ekkert, Len	215/252
	F	US-6,085,921	07-2000	Brown, Robert	215/252
	G	US-6,116,442	09-2000	Higgins, Phillip	215/252
	Н	US-6,152,316	11-2000	Niese, Richard B.	215/252
	ı	US-6,220,466	04-2001	Hayes et al.	215/276
	J	US-6,253,939	07-2001	Wan et al.	215/252
	К	US-6,276,543	08-2001	German et al.	215/252
	L	US-6,325,227	12-2001	Ekkert, Len	215/252
	М	US-6,328,175	12-2001	Champagnon et al.	215/252

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	•				
	S				•	
	Т					

# **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/076,722 Examiner James N. Smalley Applicant(s)/Patent Under Reexamination SHENKAR, EMANUEL Page 4 of 4

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,405,886	06-2002	Gearhart et al.	215/252
	В	US-6,659,297	12-2003	Gregory et al.	215/252
	С	US-6,662,958	12-2003	German et al.	215/252
	D	US-6,673,298	01-2004	Krueger, David F.	264/295
	Ε.	US-6,766,916	07-2004	Ma, Mike Xiaoli	215/252
	F	US-2003/0127419	07-2003	Shenkar et al.	215/256
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	1				
	Q					
	R					
	S					
	Т					

# **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.